

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/651,288	YOSHIDA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Chanh Nguyen	2675	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0,361,471	04/1990	E.P	Inoue et al	-----
	O					
	P					
	Q					
	R					
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NON-PATENT DOCUMENTS

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